Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/684,529	LOGUE ET AL.	
Examiner	Art Unit	
Eva Yi Zheng	2634	

SEARCHED				
Class	Subclass	Date	Examiner	
375	222	7/25/2005	E.Z	
375	376	7/25/2005	E.Z	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
updated EAST and IEEE search	7/25/2005	E.Z		
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